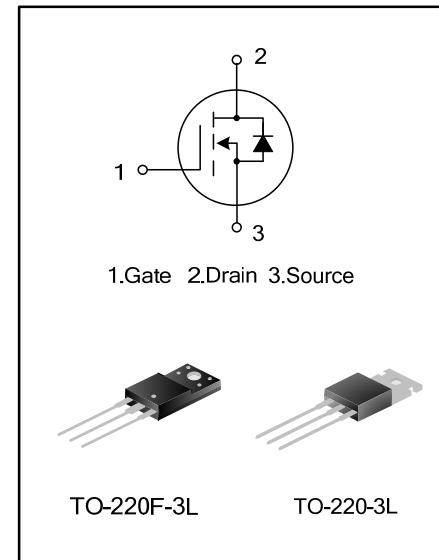


5A, 600V N-CHANNEL MOSFET

GENERAL DESCRIPTION

SVD5N60T/F is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan proprietary S-Rin™ structure DMOS technology. The improved planar stripe cell and the improved guard ring terminal have been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

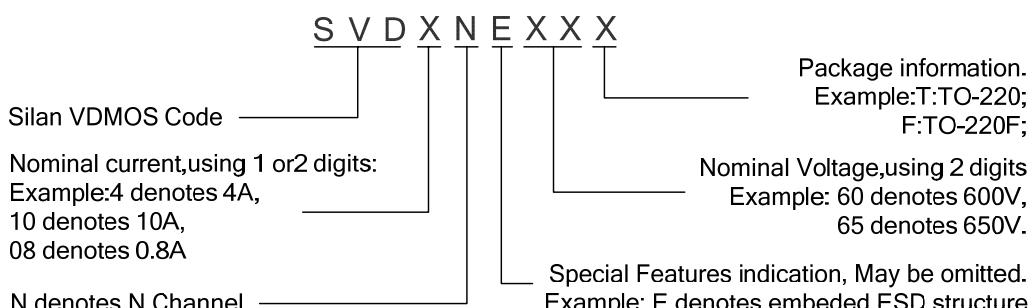
These devices are widely used in AC-DC power suppliers, DC-DC converters and H-bridge PWM motor drivers.



FEATURES

- * 5A,600V,RDS(on) (typ) = 1.7Ω @VGS=10V
- * Low gate charge
- * Low Crss
- * Fast switching
- * Improved dv/dt capability

NOMENCLATURE



ORDERING SPECIFICATIONS

Part No.	Package	Marking	Material	Packing
SVD5N60T	TO-220-3L	SVD5N60T	Pb free	Tube
SVD5N60F	TO-220F-3L	SVD5N60F	Pb free	Tube

ABSOLUTE MAXIMUM RATINGS (Tc=25°C unless otherwise noted)

Parameter	Symbol	Rating		Unit
		SVD5N60T	SVD5N60F	
Drain-Source Voltage	VDS	600		V
Gate-Source Voltage	VGS	±30		V
Drain Current	ID	5		A
Drain Current Pulsed	IDM	20		A
Power Dissipation(Tc=25°C) -Derate above 25°C	PD	120	40	W
		0.96	0.32	W/°C
Single Pulsed Avalanche Energy (Note 1)	EAS	352		mJ
Operation Junction Temperature	TJ	-55~+150		°C
Storage Temperature	Tstg	-55~+150		°C

THERMAL CHARACTERISTICS

Parameter	Symbol	Rating		Unit
		SVD5N60T	SVD5N60F	
Thermal Resistance, Junction-to-Case	RθJC	1.04	3.13	°C/W
Thermal Resistance, Junction-to-Ambient	RθJA	62.5	120	°C/W

ELECTRICAL CHARACTERISTICS (Tc=25°C unless otherwise noted)

Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain -Source Breakdown Voltage	BVDSS	VGS=0V, ID=250μA	600	--	--	V
Drain-Source Leakage Current	IDSS	VDS=600V, VGS=0V	--	--	10	μA
Gate-Source Leakage Current	IGSS	VGS=±30V, VDS=0V	--	--	±100	nA
Gate Threshold Voltage	VGS(th)	VGS= VDS, ID=250μA	2.0	--	4.0	V
Static Drain- Source On State Resistance	RDS(on)	VGS=10V, ID=2.5A	--	1.7	2.1	Ω
Input Capacitance	Ciss	VDS=25V,VGS=0V, f=1.0MHZ	--	681	--	pF
Output Capacitance	Coss		--	62	--	
Reverse Transfer Capacitance	Crss		--	7	--	
Turn-on Delay Time	td(on)	VDD=300V, ID=5.0A, RG=25Ω	--	26.7	--	ns
Turn-on Rise Time	tr		--	19	--	
Turn-off Delay Time	td(off)		--	160	--	
Turn-off Fall Time	tf		--	22	--	
Total Gate Charge	Qg	VDS=480V, ID=5.0A, VGS=10V	--	19.9	--	nC
Gate-Source Charge	Qgs		--	4.09	--	
Gate-Drain Charge	Qgd		--	7.21	--	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	IS	Integral Reverse P-N Junction Diode in the MOSFET	--	--	5.0	A
Pulsed Source Current	ISM		--	--	20	
Diode Forward Voltage	VSD	IS=5.0A, VGS=0V	--	--	1.4	V
Reverse Recovery Time	Trr	IS=5.0A, VGS=0V, dI/dt=100A/μs	--	270	--	ns
Reverse Recovery Charge	Qrr		--	1.9	--	μC

Notes:

1. L=30 mH, IAS=4.23A, VDD=195V, RG=25Ω, starting T_J=25°C;
2. Pulse Test: Pulse width ≤300μs, Duty cycle≤2%;
3. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

Figure 1. On-region Characteristics

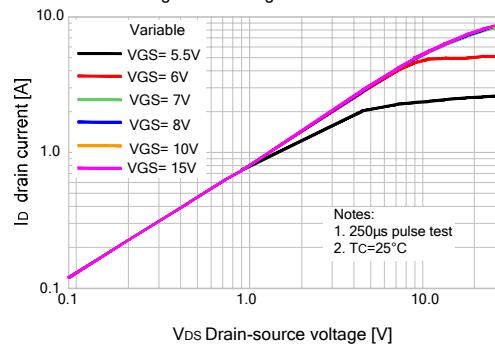


Figure 2. Transfer Characteristics

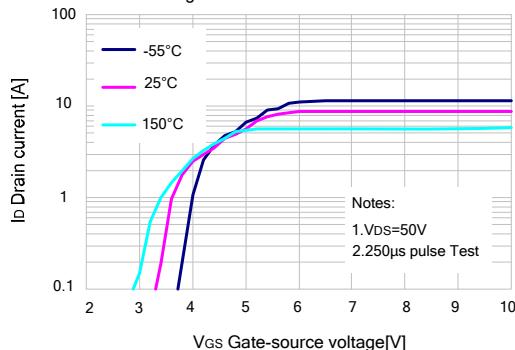


Figure 3. On-resistance variation vs. Drain current

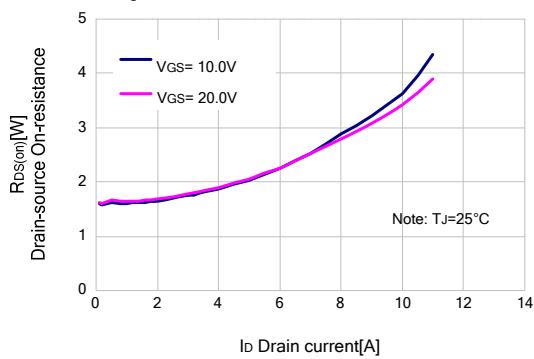
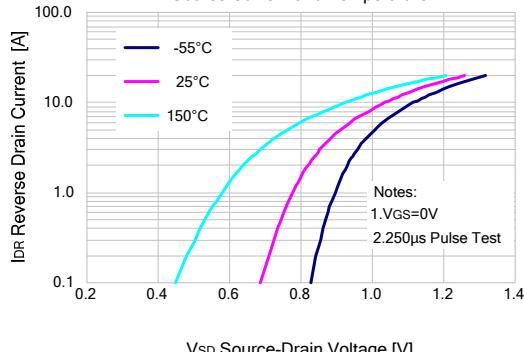


Figure 4. Body Diode Forward Voltage Variation Vs. Source Current and Temperature



TYPICAL CHARACTERISTICS(continued)

Figure 5. Breakdown Voltage Variation vs. Temperature

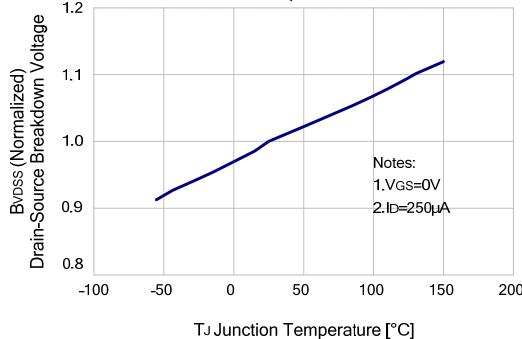


Figure 6. On-resistance Variation vs. Temperature

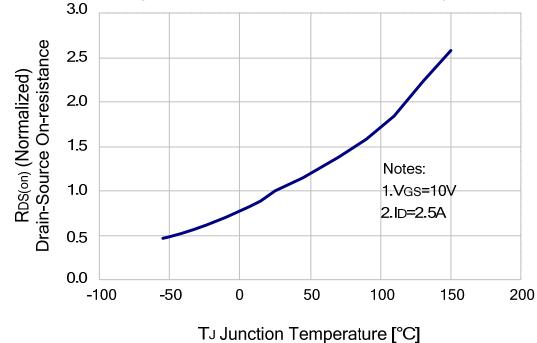


Figure 7. Capacitance Characteristics

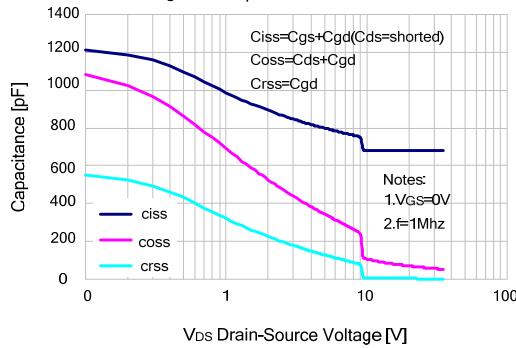


Figure 8-1. Max. Safe Operating Area(SVD5N60T)

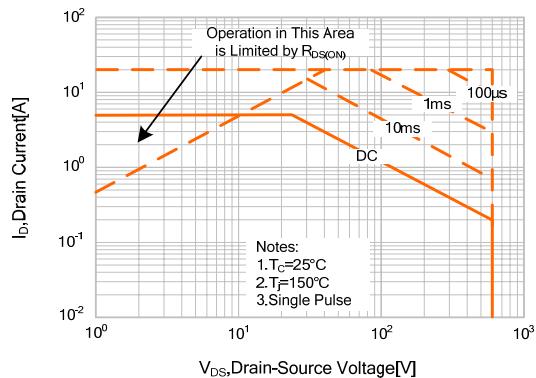


Figure 8-2. Max. Safe Operating Area(SVD5N60F)

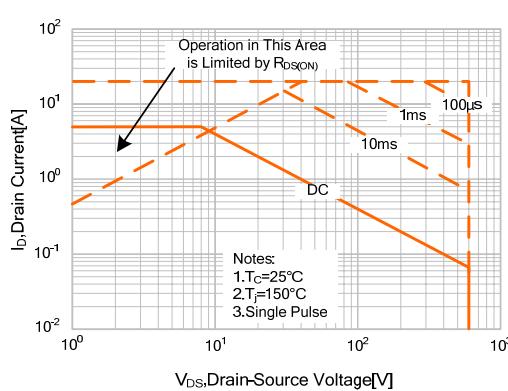
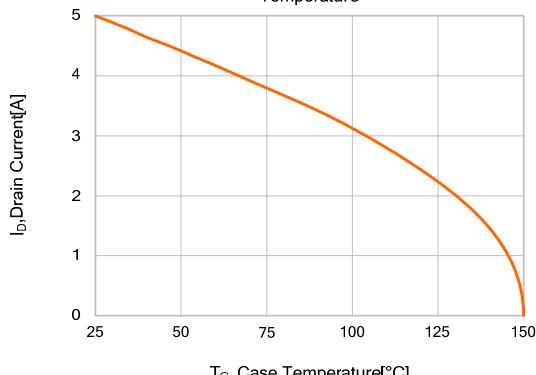
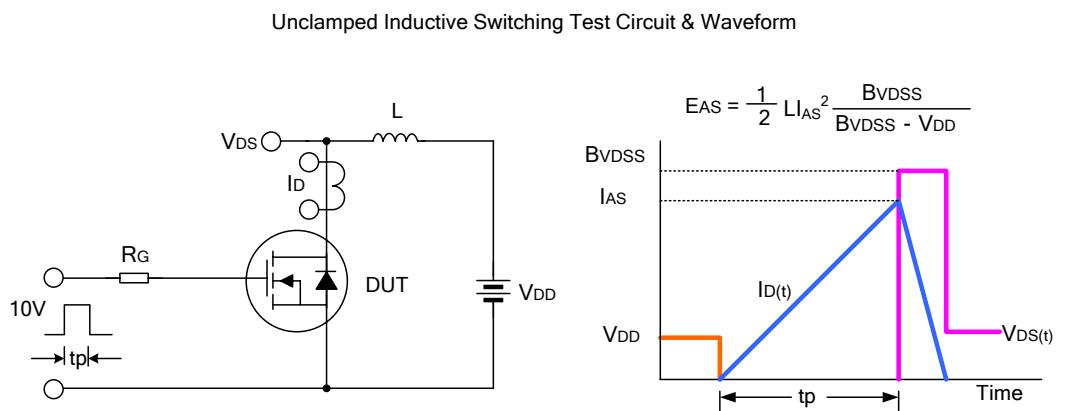
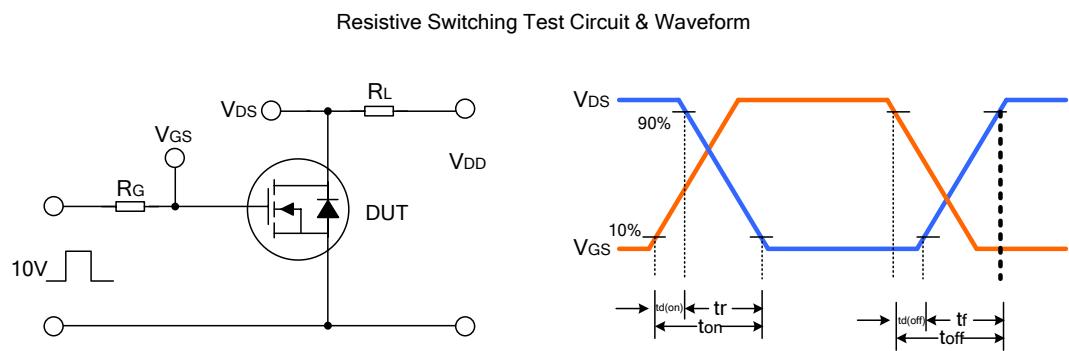
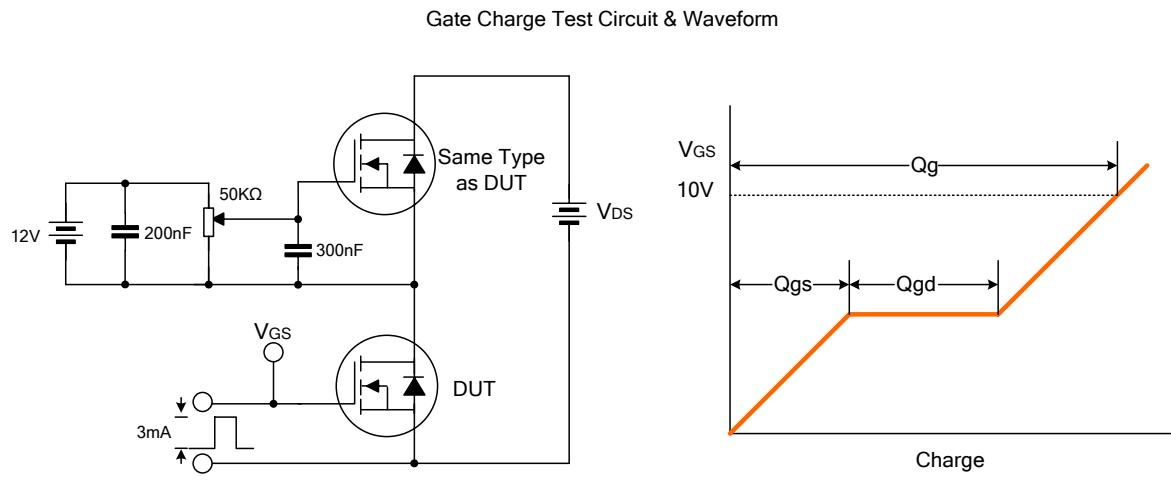


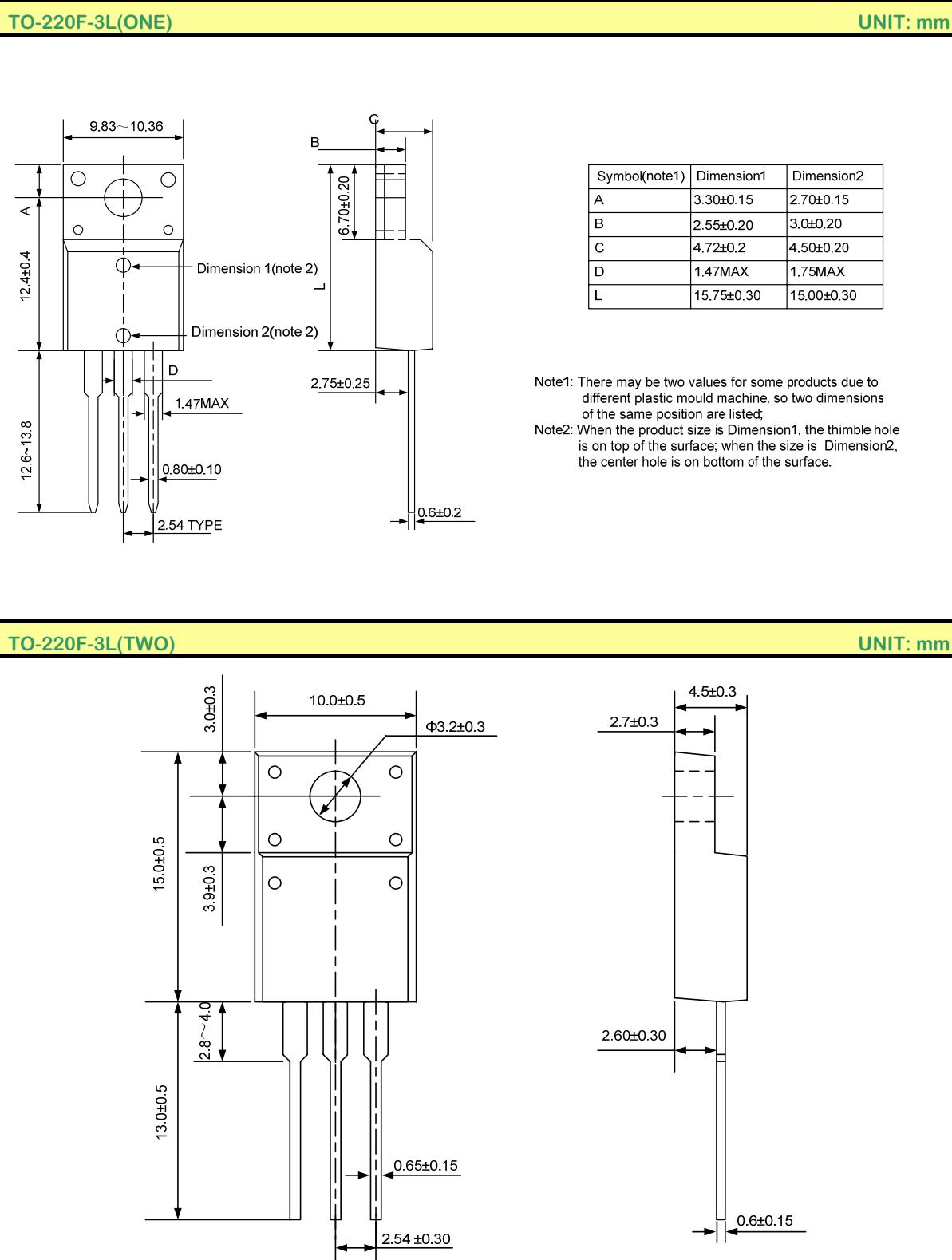
Figure 9. Maximum Drain Current vs. Case Temperature



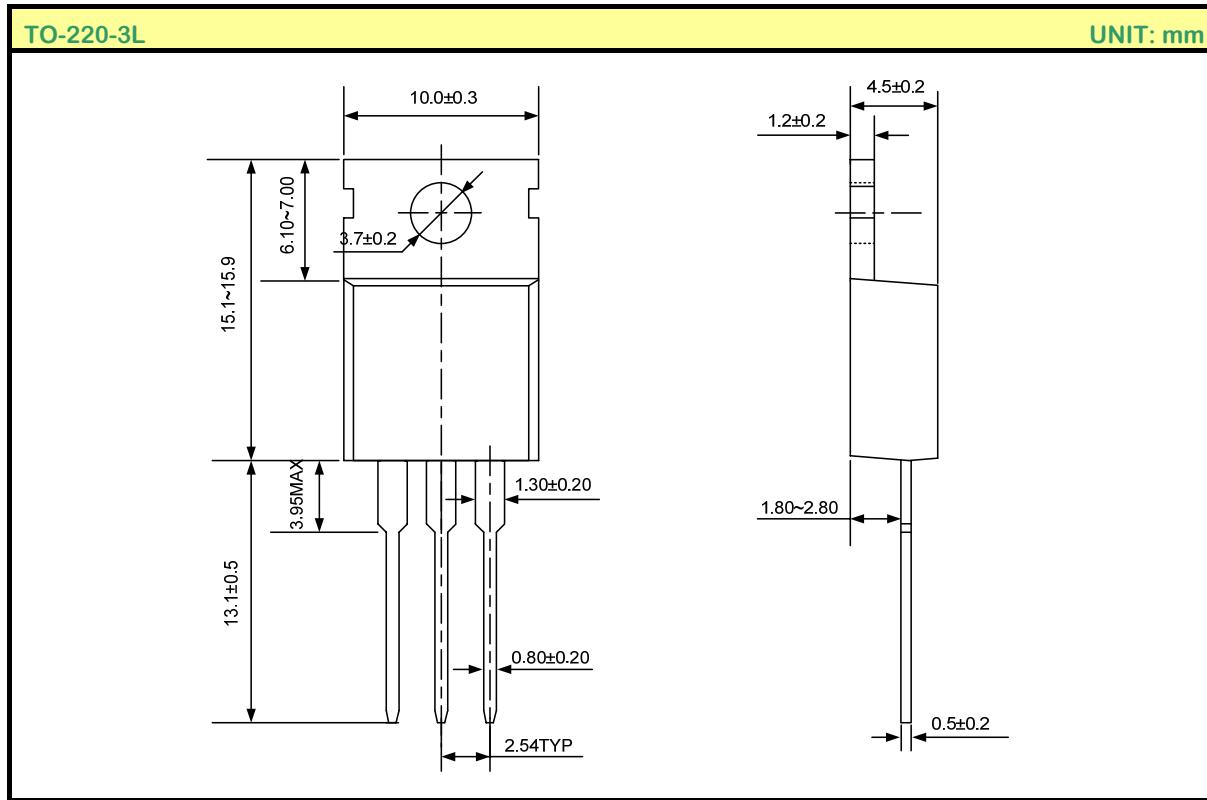
TYPICAL TEST CIRCUIT



PACKAGE OUTLINE



PACKAGE OUTLINE(continued)



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- Silan will supply the best possible product for customers!

ATTACHMENT

Revision History

Date	REV	Description	Page
2010.05.13	1.0	Original	
2010.09.15	1.1	Add lanjian TO-220F-3L package; Add SOA and ID-TC curve	
2010.10.18	1.2	Modify "TYPICAL CHARACTERISTICS"	
2010.10.19	1.3	Modify the template of Datasheet	